TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (T -MOSIV)

2SK3763

Switching Regulator Applications

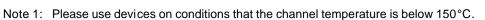
- Low drain-source ON resistance: RDS (ON) = 3.7 (typ.)
- High forward transfer admittance: $|Y_{fs}| = 2.6 \text{ S}$ (typ.)
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 720 V)$
- Enhancement-mode: $V_{th} = 2.0 \sim 4.0 V (V_{DS} = 10 V, I_D = 1 mA)$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	900	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	900	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	3	А	
	Pulse (t = 1 ms) (Note 1)	l _{DP}	9		
Drain power dissipation (Tc = 25°C)		PD	69	W	
Single pulse avalanche energy (Note 2)		E _{AS}	56.7	mJ	
Avalanche current		I _{AR}	3	А	
Repetitive avalanche energy (Note 3)		E _{AR}	6.9	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

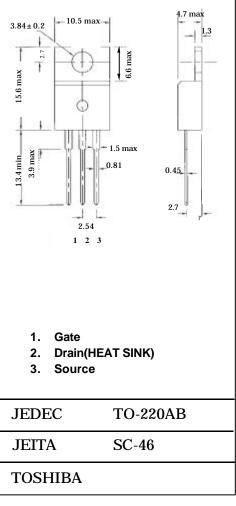
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.81	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

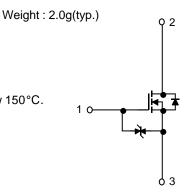


Note 2: $V_{DD} = 90 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}, \text{ L} = 11.6 \text{ mH}, \text{ I}_{AR} = 3.0 \text{ A}, \text{ R}_{G} = 25 \Omega$

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.





unit : mm

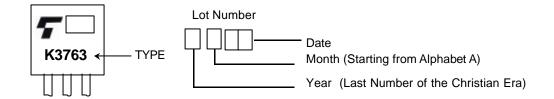
Electrical Characteristics (Ta = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		IGSS	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_		±10	μA
Gate-source brea	akdown voltage	V (BR) GSS	$I_{G} = \pm 10 \ \mu A, \ V_{GS} = 0 \ V$	±30			V
Drain cut-off curr	ent	I _{DSS}	$V_{DS} = 720 V, V_{GS} = 0 V$	_		100	μA
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900			V
Gate threshold ve	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0		4.0	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$		3.7	4.3	Ω
Forward transfer	admittance	Y _{fs}	$V_{DS} = 20 V, I_D = 1.5 A$	0.65	2.6		S
Input capacitance		C _{iss}	$V_{DS} = 25 V, V_{GS} = 0 V, f = 1 MHz$		700		pF
Reverse transfer capacitance		C _{rss}			15		
Output capacitance		Coss		_	75		
Switching time	Rise time	tr	$\begin{array}{c} 10 \text{ V} \\ \text{V}_{GS} \\ 0 \text{ V} \\ 50 \Omega \end{array} \begin{array}{c} \text{I}_{D} = 1.5 \text{ A} \text{ V}_{OUT} \\ \text{R}_{L} = \\ 133 \Omega \\ \text{V}_{DD} \simeq 200 \text{ V} \end{array}$ Duty $\leq 1\%, t_{W} = 10 \mu\text{s}$	_	20	_	ns
	Turn-on time	t _{on}			60	_	
	Fall time	t _f			35	_	
	Turn-off time	t _{off}		_	125	_	
Total gate charge		Qg		_	17		
Gate-source charge		Q _{gs}	$V_{DD} \simeq 400 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$		10		nC
Gate-drain charge		Q _{gd}			7		

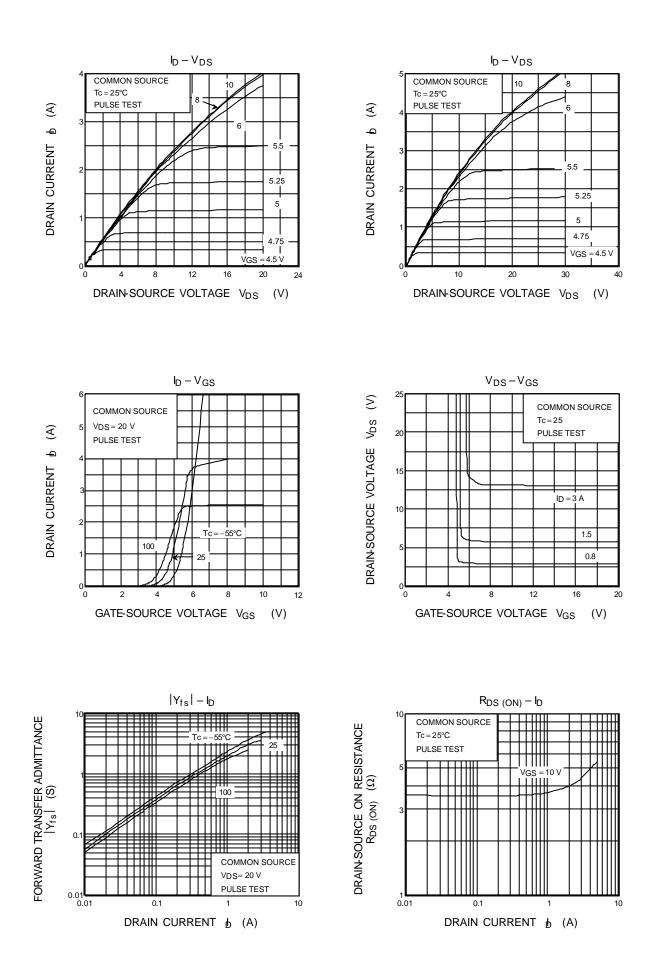
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—		_	3	А
Pulse drain reverse current (Note 1)	I DRP	—		_	9	А
Forward voltage (diode)	V _{DSF}	$I_{DR} = 3 \text{ A}, V_{GS} = 0 \text{ V}$	_		-1.9	V
Reverse recovery time	t _{rr}	$I_{DR} = 3 \text{ A}, V_{GS} = 0 \text{ V},$		850		ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 A/µs	_	4.7	_	μC

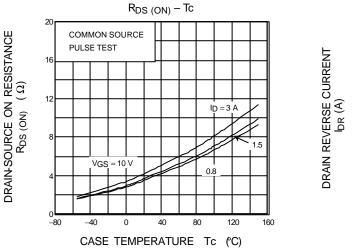
Marking

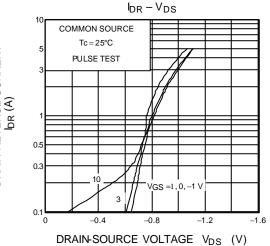


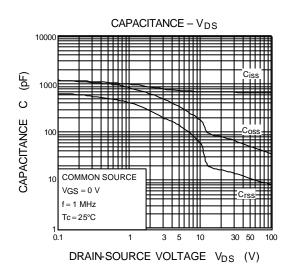
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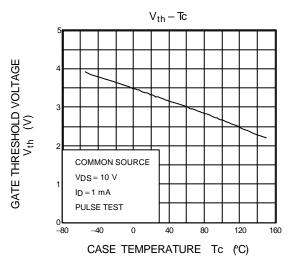


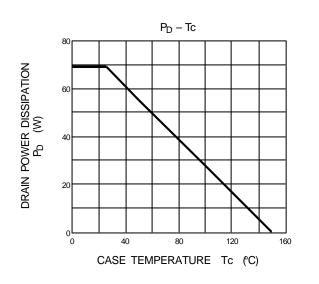
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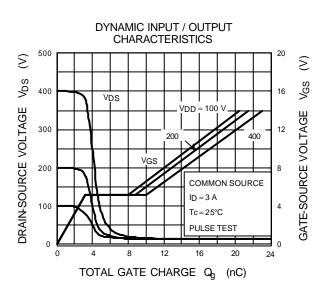


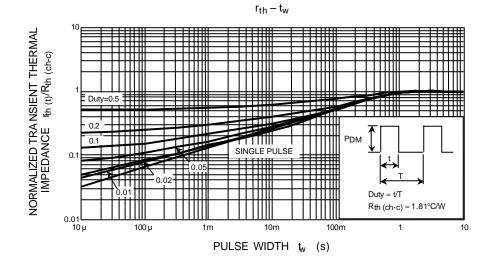


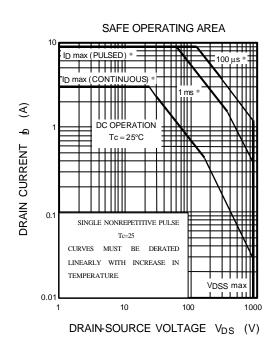


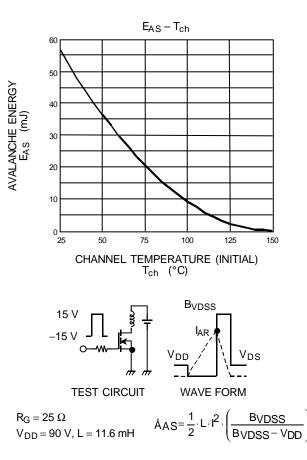












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